

Fluke 1621 Earth Ground Tester

General specifications									
Measuring functions	3-pole earth ground resistance, 2-pole ac resistance of a conductor, Interference voltage								
Intrinsic error	Refers to the reference temperature range and is guaranteed for one year								
Measuring rate	2 measurements/second								
Battery[1]	One 9 volt alkaline (LR61)								
Battery condition	LO-BAT is displayed if voltage drops below 6.5 V								
Voltages	<table border="1"> <tr> <td>Between jacks H/C2 and E/C1:</td> <td>250 Veff maximum (effective voltage)</td> </tr> <tr> <td>Between jacks S/P2 and E/C1:</td> <td>250 Veff maximum</td> </tr> </table>	Between jacks H/C2 and E/C1:	250 Veff maximum (effective voltage)	Between jacks S/P2 and E/C1:	250 Veff maximum				
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Climatic class	VDE/VDI 3540 RZ (conforming to KWG as per DIN 40040, 4/87)								
Temperature performance[2]	<table border="1"> <tr> <td>Working:</td> <td>-10 °C to +50 °C (+14 °F to +122 °F)</td> </tr> <tr> <td>Operating:</td> <td>0 °C to +35 °C (+32 °F to +95 °F)</td> </tr> <tr> <td>Storage:</td> <td>-20 °C to +60 °C (+68 °F to +140 °F)</td> </tr> <tr> <td>Reference:</td> <td>+23 °C ± 2 °C (+73 °F ± 4 °F)</td> </tr> </table>	Working:	-10 °C to +50 °C (+14 °F to +122 °F)	Operating:	0 °C to +35 °C (+32 °F to +95 °F)	Storage:	-20 °C to +60 °C (+68 °F to +140 °F)	Reference:	+23 °C ± 2 °C (+73 °F ± 4 °F)
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Reference:	+23 °C ± 2 °C (+73 °F ± 4 °F)								
Temperature coefficient	± 0.1 % of range per degree Kelvin								
Safety	IEC/EN 61010-1, 600 V CAT II, pollution degree 2								
Dimensions	113 mm x 54 mm x 216 mm (4.5 in x 2.1 in x 8.5 in), including holster								
Weight	850 g (1.9 lb), including standard accessories, volume approximately 600 cm ³								
Note:	[1]If the tester is not going to be used, or is being stored for a long period, remove the battery and store separately from the tester to avoid damage from battery leakage.								
Note:	[2]The four temperature ranges for the tester exists to satisfy European Standards requirements; the instrument can be used over the full working temperature range by using the temperature coefficient to calculate accuracy at the ambient temperature of use.								

Electrical specifications

Maximum deviations:	E₁ Influence factor	Position
	E₁ Deviation influence	0 %
	E₂ Influence factor	Supply voltage
	E₂ Deviation influence	0 %
	E₃ Influence factor	Temperature E ₃
	E₃ Deviation influence	2.3 %
	E₄ Influence factor	Serial interference voltage (20 V)
	E₄ Deviation influence	0.6 %
	E₅ Influence factor	Probe- and auxiliary probe resistance
E₅ Deviation influence	10 %	
Test voltage	3.7 kV	
Protection type	IP 40; IEC/EN 60529	
Electromagnetic	Emission: IEC/EN 61326 Class B	

compatibility	Immunity: IEC/EN 61326 Annex C	
R_E resistance measurement	Measuring method	Current-voltage measurement with improved cross-talk attenuation, no compensation of measuring lead resistance, with probe (3-pole) or without probe (2-pole), as per IEC/EN 61557-5
	Open circuit voltage	23 to 24 V ac
	Short circuit current	> 50 mA ac
	Measuring frequency	128 Hz
	Maximum permissible overload	250 V _{eff}
Measuring time	8 seconds (average from when START is pressed)	
Limit input	Tester retains set value even if instrument is turned off (assuming battery power supply is sufficient)	
Automatic changeover of resolution	R_H	< 7 kΩ
	Resolution	0.01 Ω
	R_H	< 50 kΩ
	Resolution	0.1 Ω
	R_H	> 50 kΩ
Resolution	1 Ω	
Interference voltage display dc + ac	V_{max}	30 V _{eff}
	Common mode rejection	> 80 dB at 50 Hz and 60 Hz
	R_i	680 kΩ
	Measuring uncertainty	< 10 % for pure ac and dc signals
Measuring range		
0.15 Ω to 20 Ω	Resolution	0.01 Ω
	Display range	0 to 19.99 Ω
200 Ω	Resolution	0.1 Ω
	Display range	20 to 199.9 Ω
2 kΩ	Resolution	1 Ω
	Display range	200 to 1999 Ω
Intrinsic uncertainty	± (6 % of measured value + 5D)	
Operating uncertainty IEC 61557[1]	± (18 % of measured value + 5D)	
Notes:	[1] Covers all deviations caused by influence quantities E ₁ -E ₅ . If the deviation E ₄ caused by high probe or auxiliary probe resistance is higher than specified flashes. Measured values are outside of the specified operating uncertainty.	